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APPLICATION NO. FILING DATE		FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/651,458	08/29/2003	Shunpei Yamazaki	0553-0164.01	8760	
75	590 11/02/2005	EXAMINER			
Edward D. Manzo			LE, THAO X		
Cook, Alex, Mo Cummings & M		ART UNIT	PAPER NUMBER		
	ns St., Ste. 2850	2814			
Chicago, IL 6	0606 .	DATE MAILED: 11/02/2005			

Please find below and/or attached an Office communication concerning this application or proceeding.

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Office Action Summany		Application	No.	Applicant(s)	- Uv			
		10/651,458		YAMAZAKI ET AL				
Office Action Summ	ary	Examiner	_	Art Unit				
		Thao X. Le		2814				
The MAILING DATE of this of Period for Reply	ommunication app	ears on the c	over sheet with the (correspondence ad	ldress			
A SHORTENED STATUTORY PE THE MAILING DATE OF THIS CO - Extensions of time may be available under the after SIX (6) MONTHS from the mailing date o - If the period for reply specified above, the m - Failure to reply within the set or extended perion - Any reply received by the Office later than thre earned patent term adjustment. See 37 CFR	MMUNICATION. provisions of 37 CFR 1.13 f this communication. an thirty (30) days, a reply aximum statutory period w dd for reply will, by statute, e months after the mailing	36(a). In no event, within the statutor vill apply and will ex cause the applicat	however, may a reply be tily y minimum of thirly (30) day pire SIX (6) MONTHS from ion to become ABANDONE	mely filed ys will be considered timel the mailing date of this c ED (35 U.S.C. § 133).				
Status								
1) Responsive to communication	on(s) filed on <u>12 Oc</u>	ctober 2005.						
2a) This action is FINAL .	2b)⊠ This	nis action is non-final.						
· · ·	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.							
Disposition of Claims								
4a) Of the above claim(s) 5) ☐ Claim(s) is/are allowe 6) ☒ Claim(s) <u>42-71</u> is/are rejecte 7) ☐ Claim(s) is/are object	4) Claim(s) 42-71 is/are pending in the application. 4a) Of the above claim(s) is/are withdrawn from consideration. 5) Claim(s) is/are allowed. 6) Claim(s) 42-71 is/are rejected. 7) Claim(s) is/are objected to. 8) Claim(s) are subject to restriction and/or election requirement.							
Application Papers								
9) The specification is objected 10) The drawing(s) filed on 29 Au Applicant may not request that a Replacement drawing sheet(s) 11) The oath or declaration is obj	agust 2003 is/are: any objection to the concluding the correction	a)⊠ accepte drawing(s) be I ion is required	neld in abeyance. Se if the drawing(s) is ob	e 37 CFR 1.85(a). ojected to. See 37 C	FR 1.121(d).			
Priority under 35 U.S.C. § 119			•					
12) Acknowledgment is made of a) All b) Some * c) No 1. Certified copies of the 2. Certified copies of the 3. Copies of the certified application from the In * See the attached detailed Offi	ne of: priority documents priority documents copies of the prior ternational Bureau	s have been r s have been r ity document ı (PCT Rule 1	eceived. eceived in Applicat s have been receiv 7.2(a)).	ion No. <u>09/517,54</u> ed in this National				
Attachment(s) 1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing 3) Information Disclosure Statement(s) (PTO Paper No(s)/Mail Date 10/12/05.		4) 5) 6)	Paper No(s)/Mail D		O-152)			

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DETAILED ACTION

Specification

1. The title of the invention is not descriptive. A new title is required that is clearly indicative of the invention to which the claims are directed.

Claim Rejections - 35 USC § 103

- 2. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 3. This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).
- 4. Claims 42-45, 47-49, and 51-54, 57-59, 61-69, 71 are rejected under 35 U.S.C. 103(a) as being unpatentable over US 6157429 to Kimura et al. in view of US 4839707 to Shields

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Regarding claim 42, Kimura discloses a display device in fig. 20 comprising: a glass substrate 1, col. 17 line 19, column 37 line 11, a switching transistor 221, column 20 line 27, and a current controlling transistor 223, column 20 line 28, formed on the substrate each comprising a source region a drain region, see claim 2, and a gate electrode 131, column 37 line 18, and a gate insulating film 251, column 37 line 18, an electrode (right portion next to 131) electrically connected with one of the source region and the drain region of the switching transistor 221, a dielectric layer 252, column 37 line 18, formed on the electrode (right portion of 131), a power supply line 133, column 20 line 53, fig. 1, or 213, column 27 line 45 fig. 11, electrically connected with one of the source region and the drain region of the current controlling transistors 223 and formed on the dielectric layer 252, fig. 20, a first electrode 141, column 37 line 25, electrically connected with the other one of the source region and the drain region of the current controlling transistors 223, an organic EL layer 224, column 37 line 17, formed over the first electrode 141; and a second electrode 105, column 37 line 24, formed over the organic EL layer 224.

But, Kimura does not expressly disclose the device comprising an insulating layer formed on the semiconductor substrate.

However, Shields discloses a display device in fig. 1 comprising a semiconductor layer 15, column 4 line 18, formed on an upper surface of the insulating layer 13 column 4 line 18, and a gate electrode 29, column 45 line 34, adjacent to the semiconductor layer 15 with a gate insulating 27, column 4 line 34, interposed therebetween (SOI substrate). At the time the invention was

made; it would have been obvious to one of ordinary skill in the art to use the SOI teaching of Shields with display device of Kimura, because the SOI structure would have isolated both the polysilicon layer and the device layer that would have eliminated shorts rising from leaky diodes as taught by Shields, column 3 line 55-60. Furthermore, a TFT transistor can be formed in different type substrates such as glass or semiconductor are typical in the art, see Yamada (6781155) in col. 5 lines 57-59, Aoki (6307532) in col. 17 lines 8-10, Takayama (5677549) in col. 1 line 15), or Kusumoto (5612565) in col. 4 line 10-12.

Regarding claims 43, 51, Kimura discloses a display device wherein the display device is incorporated in at least one selected from the group consisting of a portable telephone, a video camera, a mobile computer, a goggle type display, a projector, an electronic book, a digital camera, and a DVD player, fig. 24-25 column 40 lines 35-55.

Regarding claims 44, 48, Kimura discloses the display device according to claim 42, wherein the first electrode 141 overlaps the power supply line 133 (extending portion of 133 to FET 110), fig. 1 and 20.

Regarding claims 45, 49, Kimura discloses the display device, wherein the electrode (right portion next to 131) comprises one selected from the group consisting of Al, Ta and Ti, column 37 line 20.

Regarding claim 47, Kimura discloses a display device in fig. 20 comprising: a glass substrate 1, col. 17 line 19, col. 37 line 11, a p-channel switching transistor 221, column 20 line 27 and column 39 line 52, and a n-channel current controlling transistor 223, column 20 line 28 and column 30 line 25, formed on the substrate each comprising

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a source region a drain region, see claim 2, and a gate electrode 131, column 37 line 18, and a gate insulating film 251, an electrode (right portion next to 131) electrically connected with one of the source region and the drain region of the p-channel switching transistor 221, a dielectric layer 252, column 37 line 18, formed on the electrode (right portion next to 131), a power supply line 133, column 20 line 53, fig. 1, or 213, column 27 line 45 fig. 11, electrically connected with one of the source region and the drain region of the n-channel current controlling transistors 223 and formed on the dielectric layer 252, fig. 20, a first electrode 141, column 37 line 25, electrically connected with the other one of the source region and the drain region of the current controlling transistors 223, an organic EL layer 224, column 37 line 17, formed over the first electrode 141; and a second electrode 105, column 37 line 24, formed over the organic EL layer 224.

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But, Kimura does not expressly disclose the device comprising an insulating layer formed on the semiconductor substrate.

However, Shields discloses a display device in fig. 1 comprising a semiconductor layer 15, column 4 line 18, formed on an upper surface of the insulating layer 13 column 4 line 18, and a gate electrode 29, column 45 line 34, adjacent to the semiconductor layer 15 with a gate insulating 27, column 4 line 34, interposed therebetween (SOI substrate). At the time the invention was made; it would have been obvious to one of ordinary skill in the art to use the SOI teaching of Shields with display device of Kimura, because the SOI structure would have isolated both the polysilicon layer and the device layer that would have eliminated shorts rising from leaky diodes as taught by Shields, column 3

line 55-60. Furthermore, a TFT transistor can be formed in different type substrates such as glass or semiconductor are typical in the art, see Yamada (6781155) in col. 5 lines 57-59, Aoki (6307532) in col. 17 lines 8-10, Takayama (5677549) in col. 1 line 15), or Kusumoto (5612565) in col. 4 line 10-12.

Regarding claims 52, Kimura discloses a display device in fig. 20 comprising: a glass substrate 1, col. 17 line 19, column 37 line 11, a switching transistor 221, column 20 line 27, and a current controlling transistor 223, column 20 line 28, formed on the substrate each comprising a source region a drain region, see claim 2, and a gate electrode 131, column 37 line 18, and a gate insulating film 251, column 37 line 18, an electrode (right portion next to 131) electrically connected with one of the source region and the drain region of the switching transistor 221, a dielectric layer 252, column 37 line 18, formed on the electrode (right portion next to 131), a power supply line 133, column 20 line 53, fig. 1, or 213, column 27 line 45 fig. 11, electrically connected with one of the source region and the drain region of the current controlling transistors 223 and formed on the dielectric layer 252, fig. 20, a first electrode 141, column 37 line 25, electrically connected with the other one of the source region and the drain region of the current controlling transistors 223, an organic EL layer 224, column 37 line 17, formed over the first electrode 141; and a second electrode 105, column 37 line 24, formed over the organic EL layer 224.

But Kimura does not disclose a semiconductor substrate.

However, Shields discloses a display device in fig. 1 comprising a semiconductor layer 15, column 4 line 18, formed on an upper surface of the

insulating layer 13 column 4 line 18, and a gate electrode 29, column 45 line 34, adjacent to the semiconductor layer 15 with a gate insulating 27, column 4 line 34, interposed therebetween (SOI substrate). At the time the invention was made; it would have been obvious to one of ordinary skill in the art to use the SOI teaching of Shields with display device of Kimura, because the SOI structure would have isolated both the polysilicon layer and the device layer that would have eliminated shorts rising from leaky diodes as taught by Shields, column 3 line 55-60. Furthermore, a TFT transistor can be formed in different type substrates such as glass or semiconductor are typical in the art, see Yamada (6781155) in col. 5 lines 57-59, Aoki (6307532) in col. 17 lines 8-10, Takayama (5677549) in col. 1 line 15), or Kusumoto (5612565) in col. 4 line 10-12.

Regarding claims 53, 58, 63, and 68, Kimura discloses the display device wherein the first electrode 141 overlaps the power supply line 133 (extending portion of 133 to FET 110), fig. 1 and 20.

Regarding claims 54, 59, 64, and 69, Kimura discloses the display device wherein the electrode (right portion of 131) comprises one selected from the group consisting of Al, Ta and Ti, column 37 line 20.

Regarding claims 61 65-66, and 71, Kimura discloses a display device wherein the display device is incorporated in at least one selected from the group consisting of a portable telephone, a video camera, a mobile computer, a goggle type display, a projector, an electronic book, a digital camera, and a DVD player, fig. 24-25 column 40 lines 35-55.

Regarding claim 57, Kimura discloses a display device in fig. 20 comprising: a glass substrate 1, col. 17 line 19, column 37 line 11, a p-channel switching transistor 221, column 20 line 27 and column 39 line 52, and a n-channel current controlling transistor 223, column 20 line 28 and column 30 line 25, formed on the substrate each comprising a source region a drain region, see claim 2, and a gate electrode 131. column 37 line 18, and a gate insulating film 251, an electrode (right portion next to 131) electrically connected with one of the source region and the drain region of the pchannel switching transistor 221, a dielectric layer 252, column 37 line 18, formed on the electrode (right portion next to 131), a power supply line 133, column 20 line 53, fig. 1, or 213, column 27 line 45 fig. 11, electrically connected with one of the source region and the drain region of the n-channel current controlling transistors 223 and formed on the dielectric layer 252, fig. 20, a first electrode 141, column 37 line 25, electrically connected with the other one of the source region and the drain region of the n-channel type current controlling transistors 223, fig. 20, an organic EL layer 224, column 37 line 17, formed over the first electrode 141; and a second electrode 105, column 37 line 24, formed over the organic EL layer 224.

But Kimura does not disclose a semiconductor substrate.

However, Shields discloses a display device in fig. 1 comprising a semiconductor layer 15, column 4 line 18, formed on an upper surface of the insulating layer 13 column 4 line 18, and a gate electrode 29, column 45 line 34, adjacent to the semiconductor layer 15 with a gate insulating 27, column 4 line 34, interposed therebetween (SOI substrate). At the time the invention was

made; it would have been obvious to one of ordinary skill in the art to use the SOI teaching of Shields with display device of Kimura, because the SOI structure would have isolated both the polysilicon layer and the device layer that would have eliminated shorts rising from leaky diodes as taught by Shields, column 3 line 55-60. Furthermore, a TFT transistor can be formed in different type substrates such as glass or semiconductor are typical in the art, see Yamada (6781155) in col. 5 lines 57-59, Aoki (6307532) in col. 17 lines 8-10, Takayama (5677549) in col. 1 line 15), or Kusumoto (5612565) in col. 4 line 10-12.

Regarding claims 62, Kimura discloses a display device in fig. 20 comprising: a glass substrate 1, col. 17 line 19, column 37 line 11, a switching transistor 221, column 20 line 27, and a current controlling transistor 223, column 20 line 28, formed on the substrate each comprising a source region a drain region, see claim 2, and a gate electrode 131, column 37 line 18, and a gate insulating film 251, column 37 line 18, an electrode (right portion next to 131) electrically connected with one of the source region and the drain region of the switching transistor 221, a dielectric layer 252, column 37 line 18, formed on the electrode (right portion next to 131), a power supply line 133, column 20 line 53, fig. 1, or 213, column 27 line 45 fig. 11, electrically connected with one of the source region and the drain region of the current controlling transistors 223 and formed on the dielectric layer 252, fig. 20, a storage capacitor comprising the electrode (right portion nest to 131), the dielectric layer 252, and the power supply line 133, fig. 20, a first electrode 141, column 37 line 25, electrically connected with the other one of the source region and the drain region of the current controlling transistors

223, an organic EL layer 224, column 37 line 17, formed over the first electrode 141; and a second electrode 105, column 37 line 24, formed over the organic EL layer 224.

But Kimura does not disclose a semiconductor substrate.

However, Shields discloses a display device in fig. 1 comprising a semiconductor layer 15, column 4 line 18, formed on an upper surface of the insulating layer 13 column 4 line 18, and a gate electrode 29, column 45 line 34, adjacent to the semiconductor layer 15 with a gate insulating 27, column 4 line 34, interposed therebetween (SOI substrate). At the time the invention was made; it would have been obvious to one of ordinary skill in the art to use the SOI teaching of Shields with display device of Kimura, because the SOI structure would have isolated both the polysilicon layer and the device layer that would have eliminated shorts rising from leaky diodes as taught by Shields, column 3 line 55-60. Furthermore, a TFT transistor can be formed in different type substrates such as glass or semiconductor are typical in the art, see Yamada (6781155) in col. 5 lines 57-59, Aoki (6307532) in col. 17 lines 8-10, Takayama (5677549) in col. 1 line 15), or Kusumoto (5612565) in col. 4 line 10-12.

With respect to storage capacitor, Kimura obviously discloses a capacitor that normally comprises a two electrodes and a dielectric layer interposes between two electrodes.

Regarding claim 67, Kimura discloses a display device in fig. 20 comprising: a glass substrate 1, col. 17 line 19, column 37 line 11, a p-channel switching transistor 221, column 20 line 27 and column 39 line 52, and a n-channel current controlling

transistor 223, column 20 line 28 and column 30 line 25, formed on the substrate each comprising a source region a drain region, see claim 2, and a gate electrode 131, column 37 line 18, and a gate insulating film 251, an electrode (right portion next to 131) electrically connected with one of the source region and the drain region of the pchannel switching transistor 221, a dielectric layer 252, column 37 line 18, formed on the electrode (right portion next to 131), a power supply line 133, column 20 line 53, fig. 1, or 213, column 27 line 45 fig. 11, electrically connected with one of the source region and the drain region of the n-channel current controlling transistors 223 and formed on the dielectric layer 252, fig. 20, a storage capacitor comprising the electrode (right portion nest to 131), the dielectric layer 252, and the power supply line 133, fig. 20, a first electrode 141, column 37 line 25, electrically connected with the other one of the source region and the drain region of the n-channel type current controlling transistors 223, fig. 20, an organic EL layer 224, column 37 line 17, formed over the first electrode 141; and a second electrode 105, column 37 line 24, formed over the organic EL layer 224.

But Kimura does not disclose a semiconductor substrate.

However, Shields discloses a display device in fig. 1 comprising a semiconductor layer 15, column 4 line 18, formed on an upper surface of the insulating layer 13 column 4 line 18, and a gate electrode 29, column 45 line 34, adjacent to the semiconductor layer 15 with a gate insulating 27, column 4 line 34, interposed therebetween (SOI substrate). At the time the invention was made; it would have been obvious to one of ordinary skill in the art to use the SOI

teaching of Shields with display device of Kimura, because the SOI structure would have isolated both the polysilicon layer and the device layer that would have eliminated shorts rising from leaky diodes as taught by Shields, column 3 line 55-60. Furthermore, a TFT transistor can be formed in different type substrates such as glass or semiconductor are typical in the art, see Yamada (6781155) in col. 5 lines 57-59, Aoki (6307532) in col. 17 lines 8-10, Takayama (5677549) in col. 1 line 15), or Kusumoto (5612565) in col. 4 line 10-12.

With respect to storage capacitor, Kimura obviously discloses a capacitor that normally comprises a two electrodes and a dielectric layer interposes between two electrodes.

5. Claims 46, 50 are rejected under 35 U.S.C. 103(a) as being unpatentable over US 6157429 to Kimura et al. and US 4839707 to Shields as applied to the above claims 42 and 47 and further in view of US 5733661 to Ue et al.

Regarding claims 46, 50, Kimura does not disclose the display device wherein the electrode comprises oxidation film of the electrode.

However, Ue discloses a electrode 1, fig. 2, consists of Ta, Ti, or Ta, column 3 line 64, having a oxidation film 2, fig. 2, column 1 lines 19-22 or column 4 lines 1-5. At the time the invention was made; it would have been obvious to one of ordinary skill in the art to use the aluminum electrode teaching of Shields and oxidation film of Ue with Kimura's device, because anodization would have created a metal oxide layer having high electrical insulation properties and function to permits electric current to flow therethrough in one direction and can

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be used as a protective film for wiring in liquid crystal device as taught by Ue, column 1 lines 23-38, and column 4 line 10.

6. Claims 55, 60, 65, and 71 are rejected under 35 U.S.C. 103(a) as being unpatentable over US 6157429 to Kimura et al. and US 4839707 to Shields as applied to the above claims and further in view of US 5733661 to Ue et al.

Regarding claims 55, 60, 65, and 71, Kimura does not disclose the display device wherein the dielectric comprises an oxidation film of the electrode.

However, Ue discloses a electrode 1, fig. 2, consists of Ta, Ti, or Ta, column 3 line 64, having a oxidation film 2, fig. 2, column 1 lines 19-22 or column 4 lines 1-5. At the time the invention was made; it would have been obvious to one of ordinary skill in the art to use the aluminum electrode teaching of Shields and oxidation film of Ue with Kimura's device, because anodization would have created a metal oxide layer having high electrical insulation properties and function to permits electric current to flow therethrough in one direction and can be used as a protective film for wiring in liquid crystal device as taught by Ue, column 1 lines 23-38, and column 4 line 10.

Response to Arguments

7. Applicant's arguments with respect to claims 42-71 have been considered but are most in view of the new ground(s) of rejection.

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Conclusion

8. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Thao X. Le whose telephone number is (571) 272-1708. The examiner can normally be reached on M-F from 8:00 AM - 4:30 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Wael M. Fahmy can be reached on (571) 272 -1705. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Thao X. Le

Patent Examiner 31 Oct. 2005